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LOW FREQUENCY RAMAN SCATTERING IN MIXED $Ga_{1-x}Al_xAs$ AND $Ga_{1-x}In_xAs$ ALLOYS

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<u>Abstract.</u> We report Raman studies of disorder induced scattering in the $Ga_{1-x}AI_xAs$ and $Ga_{1-x}In_xAs$ alloys. Previous results [1] are confirmed for the $Ga_{1-x}AI_xAs$ system for a wider range of concentration. The role of the substituant is discussed through the analysis of the $Ga_{1-x}In_xAs$ system.

<u>Introduction</u>.- To extend results on a $Ga_{0.80}Al_{0.20}As$ crystal [1] we performed experiments to a concentration of Al equals 0.50. Mass and size effects related to the nature of the substituant are analyzed on the $Ga_{1-x}In_xAs$ system.

<u>Results and discussion</u>.- All experimental details are provided in reference [1]. All the samples used in the present work were layers L.P.E. grown on a the (100) face of GaAs substrate.

Figures 1 and 2 display, respectively, the results obtained, at 300 K, for $Ga_{1-x}Al_xAs$ and $Ga_{1-x}In_xAs$. Although the exciting laser wavelengths are different (see figure captions) resonance effects are excluded.

As in reference [1] we find that, except for the GaAs $LO(\Gamma)$ mode, the crystalline symmetry is also lost for the $Ga_{1-x}In_xAs$ alloys. Therefore we give only two types of spectra in figures 1 an 2. a(b) refers to crossed (parallel) polarizations of the incident and scattered lights and corresponds to the $\Gamma_{15}(\Gamma_1 + 4 \Gamma_{12})$ Raman cross section [1].

Let us first compare for the same concentration (x = 0.20) the spectra of the two alloys.

The main effect of the substituant appears for the long wavelength optical modes and is related to mass effects $(m_{Al} < m_{Ga} < m_{In})$. Indeed a AlAs-like band stems above the frequency of the LO(Γ) in GaAs. This band merges into the local mode of Al in GaAs as x reaches zero. On the contrary for the Ga_{1-x}In_xAs compounds a structure shows up below the LO(Γ) around 235 cm⁻¹. It gives for x = 0.09 a shoulder (fig. 2) which materializes clearly the impurity mode of In in GaAs. As there is no gap in the phonon density of states of GaAs [2] it is an in-band mode and denoted ω_b (In:GaAs). The symmetry of this mode is Γ_{15} (see fig. 2) as expected theoretically.

The structure at 265 cm⁻¹(fig. 1), which is attributed in reference [1] to GaAs



<u>Fig. 1</u> - Raman spectra observed, at 300 K, for three $Ga_{1-x}AI_xAs$ samples. The exciting laser wavelengths are $\lambda = 5 308$ Å for x = 0.20 and $\lambda = 5 145$ Å for x = 0.35 and 0.50.



<u>Fig. 2</u> - Raman spectra observed, at 300 K, for three $Ga_{1-x}In_xAs$ samples. The exciting laser wavelengths are $\lambda = 4.880$ Å for x = 0.09 and x = 0.20, $\lambda = 5.308$ Å for x = 0.40.

disorded activated transverse optical processes (D.A.T.O.), is also present in the $Ga_{1-x}In_xAs$ system (fig. 2) whereas the D.A.L.O. of GaAs (fig. 1) is obscured by the InAs-like band. This one is noted D.A.O. (fig. 2) as it is hard to distinguish between longitudinal and transverse processes.

In the low frequency range the D.A.T.A., 2 TA, and D.A.L.A. modes appear also in the $Ga_{1-x}In_xAs$ alloys although the structures are less resolved. Their frequencies are shifted to lower energies compared to those found in GaAs [1], due to mass effects, as expected. They increase in $Ga_{1-x}Al_xAs$ for the same reason.

The shift to lower energy of the acoustical branches in the $Ga_{1-x}In_xAs$ system allows to resolve the 2 IA band while it lies within the D.A.L.O. of GaAs for $Ga_{1-x}Al_xAs$.

The assignement of the structures discussed above for x = 0.20 are confirmed by the variations of their frequencies, widths and intensities upon concentration.

As already mentionned spectra are less structured for the $Ga_{1-x}In_xAs$ system. In the acoustical range this is related in part, to the larger width of the 2 TA band. Due to the bigger size of In, the substitution of In to Ga introduces a distorsion of the bond length much more important than the one produced by the substitution of Al (the bond lengths in GaAs, AlAs and InAs are respectively 2.447 Å, 2.452 Å and 2.615 Å). This effect induces a larger amount of disorder in the $Ga_{1-x}In_xAs$ system and consequently should lead to wider structures.

The same reason could explain that, for each concentration, the width of the D.A.T.A. is larger by an amount of 7 cm^{-1} , on the average, in the Ga_{1-x}In_xAs alloys. In the same way, the width of the LO(GaAs) band increases by a factor 2.7(1.8) when the concentration of In(Al) goes from 0 to 0.5.

The intensities of the disorder induced bands reflect the degree of disorder of the alloy. As a matter of fact the relative intensities of the D.A.T.A. and the D.A.L.A. to that of the 2TA band increase (fig. 1 and 2) with x as the latter is reminescent of the order of the perfect crystal. To evaluate more quantitatively the degree of disorder it is convenient to refer to the intensity of the D.A.T.A. which is well seen in the two alloys. Indeed the ratio I(D.A.T.A.) / (1-x) I[LO(GaAs)] increases with x.

In figures 1-b one notices also that the intensities of the D.A.L.O. and the D.A.T.O. of GaAs increase in a way similar to that of the D.A.L.A. Also the D.A.O. of AlAs get stronger with x.

The "depolarization spectrum" introduced by Kobliska and Solin in the case of amorphous materials [3] can be measured in the alloys. As all the spectra have been recorded with the same instrumental transfer fonction, for each concentration, the depolarization ratio ρ is given by the ratio of the intensity of spectrum a over that of spectrum b.One deduces from fig. 1 and 2 that $\rho(D.A.T.A.)$, for example, increases with x and reaches its maximum value when the disorder is the greatest for x = 0.5. As displays in figures 1 and 2 ρ is dispersive, indeed $\rho(D.A.L.A.) < \rho(D.A.T.A.)$. This implies that the vibrations which correspond to the D.A.L.A. are more symetrical than those of the D.A.T.A. in agreement with the conclusions of London [4] relative to defect activated Raman processes in zinc-blende type crystals. As a matter of fact, although longitudinal and transverse acoustical phonons at X and L become Raman active, the symmetry of the longitudinal is in part Γ_1 -like while the one of the transverse is never Γ_1 . One should point out that the Γ_1 symmetry of the D.A.L.A.

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